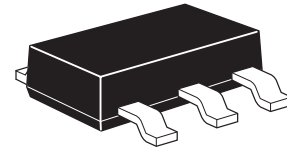


# ZXMN6A25G

## 60V SOT223 N-channel enhancement mode MOSFET

### Summary

$V_{(BR)DSS}$	$R_{DS(on)}$ ( $\Omega$ )	$I_D$ (A)
60	0.050 @ $V_{GS} = 10V$	6.7
	0.070 @ $V_{GS} = 4.5V$	5.7



### Description

This new generation trench MOSFET from Zetex features a unique structure combining the benefits of low on-resistance and fast switching, making it ideal for high efficiency power management applications.

### Features

- Low on-resistance
- Fast switching speed
- Low gate drive
- SOT223 package

### Applications

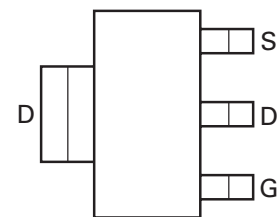
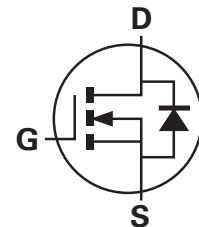
- DC-DC converters
- Power management functions
- Disconnect switches
- Motor control

### Ordering information

Device	Reel size (inches)	Tape width (mm)	Quantity per reel
ZXMN6A25GTA	7	12	1,000

### Device marking

ZXMN  
6A25



Pinout - top view

# ZXMN6A25G

## Absolute maximum ratings

Parameter	Symbol	Limit	Unit
Drain-source voltage	$V_{DSS}$	60	V
Gate-source voltage	$V_{GS}$	$\pm 20$	V
Continuous drain current @ $V_{GS} = 10V$ ; $T_{amb} = 25^{\circ}C^{(b)}$ @ $V_{GS} = 10V$ ; $T_{amb} = 70^{\circ}C^{(b)}$ @ $V_{GS} = 10V$ ; $T_{amb} = 25^{\circ}C^{(a)}$	$I_D$	6.7	A
		5.4	A
		4.8	A
Pulsed drain current <sup>(c)</sup>	$I_{DM}$	28.5	A
Continuous source current (body diode) <sup>(b)</sup>	$I_S$	5.7	A
Pulsed source current (body diode) <sup>(c)</sup>	$I_{SM}$	28.5	A
Power dissipation at $T_{amb} = 25^{\circ}C^{(a)}$	$P_D$	2	W
Linear derating factor		16	mW/ $^{\circ}C$
Power dissipation at $T_{amb} = 25^{\circ}C^{(b)}$	$P_D$	3.9	W
Linear derating factor		31	mW/ $^{\circ}C$
Operating and storage temperature range	$T_j, T_{stg}$	-55 to +150	$^{\circ}C$

## Thermal resistance

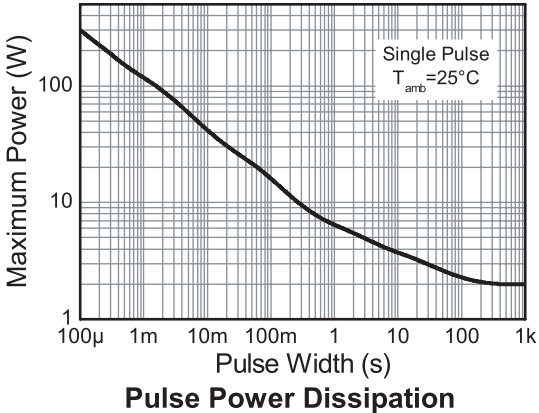
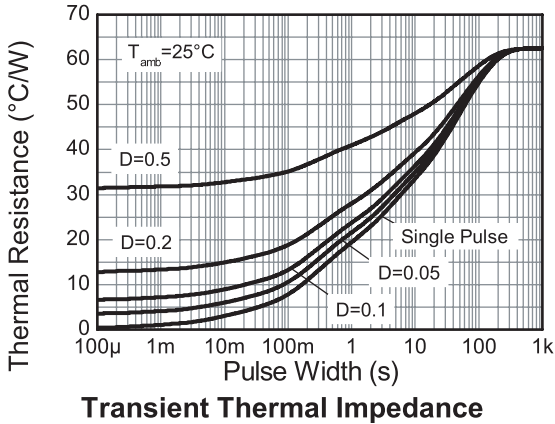
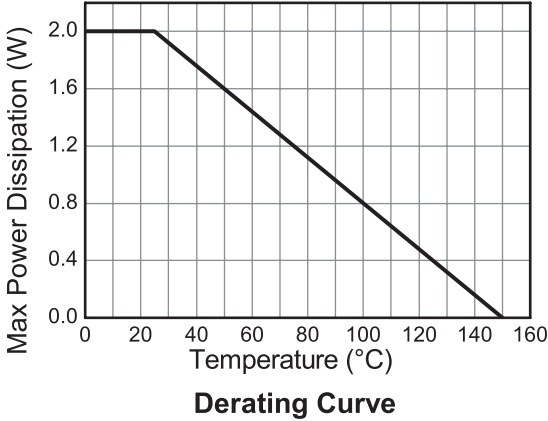
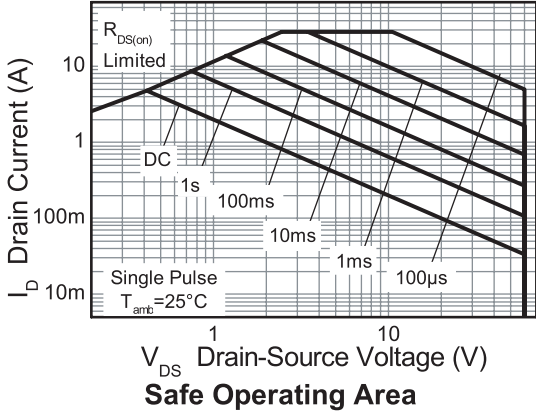
Parameter	Symbol	Limit	Unit
Junction to ambient	$R_{\theta JA}$	62.5	$^{\circ}C/W$
Junction to ambient	$R_{\theta JA}$	32	$^{\circ}C/W$

### NOTES:

- (a) For a device surface mounted on 25mm x 25mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.
- (b) For a device surface mounted on FR4 PCB measured at  $t \leq 10$  sec.
- (c) Repetitive rating - 25mm x 25mm FR4 PCB,  $D=0.02$ , pulse width 300 $\mu s$  - pulse width limited by maximum junction temperature.

# ZXMN6A25G

## Typical characteristics



# ZXMN6A25G

## Electrical characteristics (at $T_{amb} = 25^{\circ}\text{C}$ unless otherwise stated)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
<b>STATIC</b>						
Drain-source breakdown voltage	$V_{(BR)DSS}$	60			V	$I_D = 250\mu\text{A}$ , $V_{GS} = 0\text{V}$
Zero gate voltage drain current	$I_{DSS}$			1.0	$\mu\text{A}$	$V_{DS} = 60\text{V}$ , $V_{GS} = 0\text{V}$
Gate-body leakage	$I_{GSS}$			100	nA	$V_{GS} = \pm 20\text{V}$ , $V_{DS} = 0\text{V}$
Gate-source threshold voltage	$V_{GS(th)}$	1			V	$I_D = 250\mu\text{A}$ , $V_{DS} = V_{GS}$
Static drain-source on-state resistance <sup>(*)</sup>	$R_{DS(on)}$			0.050	$\Omega$	$V_{GS} = 10\text{V}$ , $I_D = 3.6\text{A}$
				0.070	$\Omega$	$V_{GS} = 4.5\text{V}$ , $I_D = 3.0\text{A}$
Forward transconductance <sup>(*)</sup> (‡)	$g_{fs}$		10.2		S	$V_{DS} = 15\text{V}$ , $I_D = 4.5\text{A}$
<b>Dynamic<sup>(‡)</sup></b>						
Input capacitance	$C_{iss}$		1063		pF	$V_{DS} = 30\text{V}$ , $V_{GS} = 0\text{V}$ $f = 1\text{MHz}$
Output capacitance	$C_{oss}$		104		pF	
Reverse transfer capacitance	$C_{rss}$		64		pF	
<b>Switching<sup>(†)</sup> (‡)</b>						
Turn-on-delay time	$t_{d(on)}$		3.8		ns	$V_{DD} = 30\text{V}$ , $I_D = 1\text{A}$ $R_G \cong 6.0\Omega$ , $V_{GS} = 10\text{V}$
Rise time	$t_r$		4.0		ns	
Turn-off delay time	$t_{d(off)}$		26.2		ns	
Fall time	$t_f$		10.6		ns	
Gate charge	$Q_g$		11.0		nC	$V_{DS} = 30\text{V}$ , $V_{GS} = 5\text{V}$ $I_D = 1.4\text{A}$
Total gate charge	$Q_g$		20.4		nC	$V_{DS} = 30\text{V}$ , $V_{GS} = 10\text{V}$ $I_D = 1.4\text{A}$
Gate-source charge	$Q_{gs}$		4.1		nC	
Gate Drain Charge	$Q_{gd}$		5.1		nC	
<b>Source-drain diode</b>						
Diode forward voltage <sup>(*)</sup>	$V_{SD}$		0.85	0.95	V	$T_j = 25^{\circ}\text{C}$ , $I_S = 5.5\text{A}$ , $V_{GS} = 0\text{V}$
Reverse recovery time <sup>(‡)</sup>	$t_{rr}$		22.0		ns	$T_j = 25^{\circ}\text{C}$ , $I_S = 2.2\text{A}$ , $di/dt = 100\text{A}/\mu\text{s}$
Reverse recovery charge <sup>(‡)</sup>	$Q_{rr}$		21.4		nC	

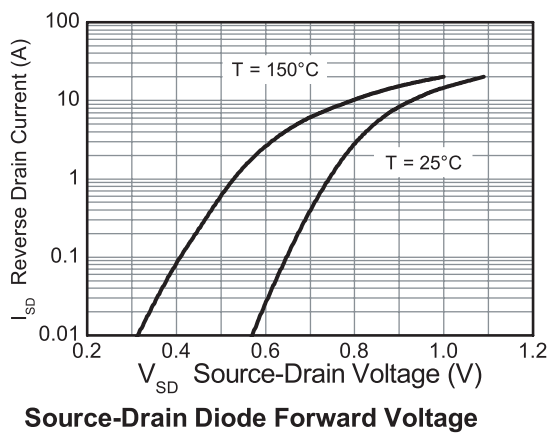
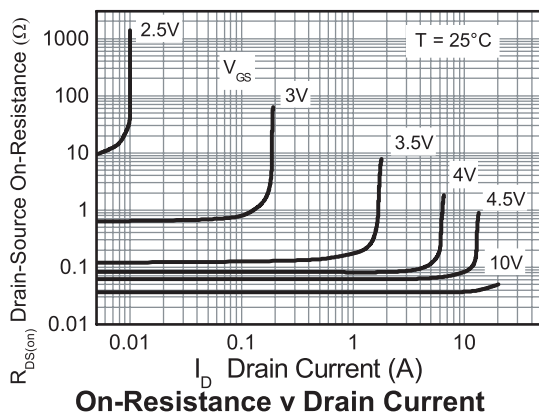
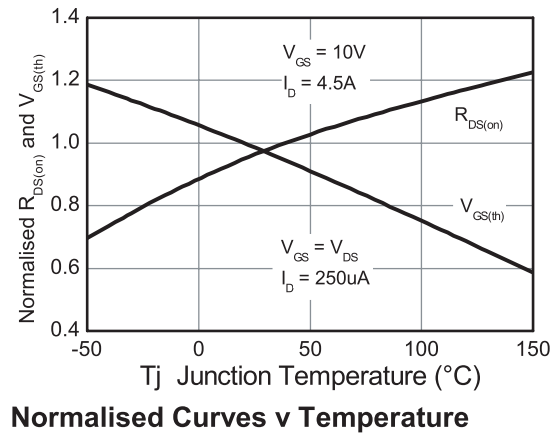
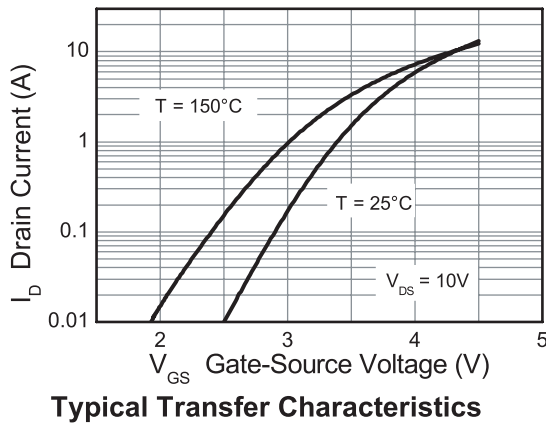
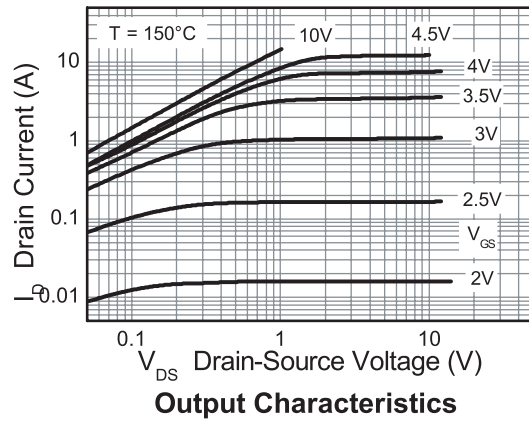
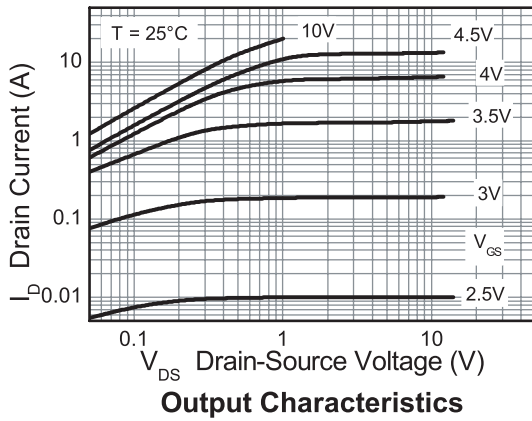
### NOTES:

(\*) Measured under pulsed conditions. Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .

(†) Switching characteristics are independent of operating junction temperature.

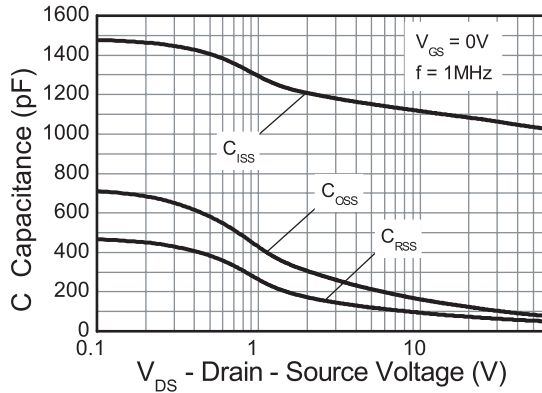
(‡) For design aid only, not subject to production testing.

## Typical characteristics

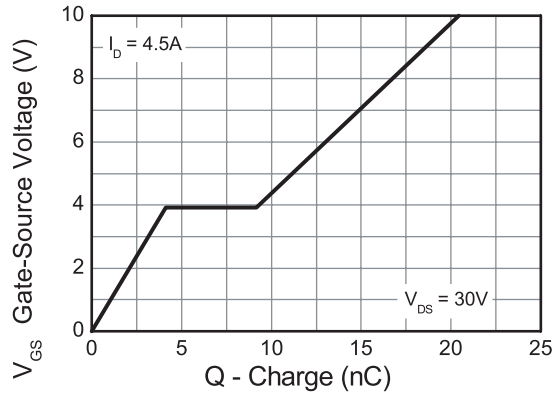


# ZXMN6A25G

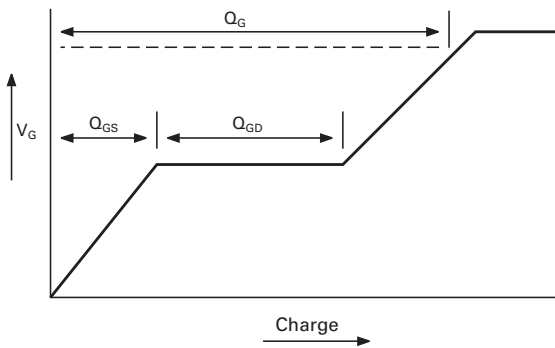
## Typical characteristics



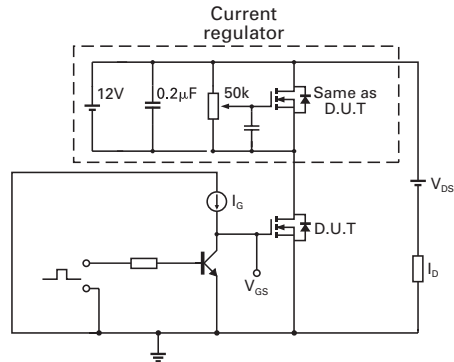
Capacitance v Drain-Source Voltage



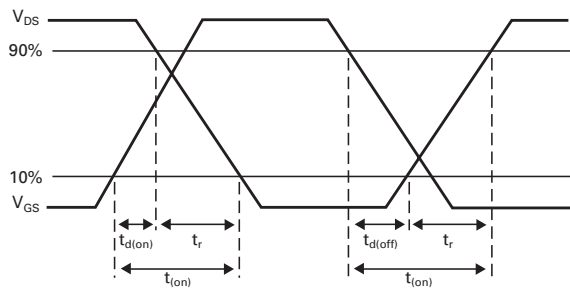
Gate-Source Voltage v Gate Charge



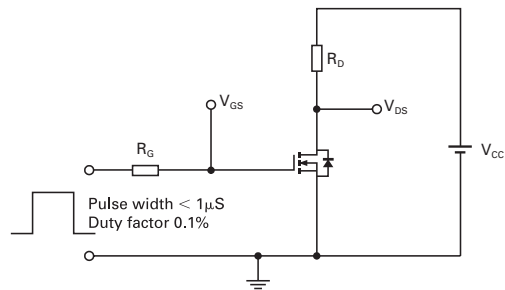
Basic gate charge waveform



Gate charge test circuit



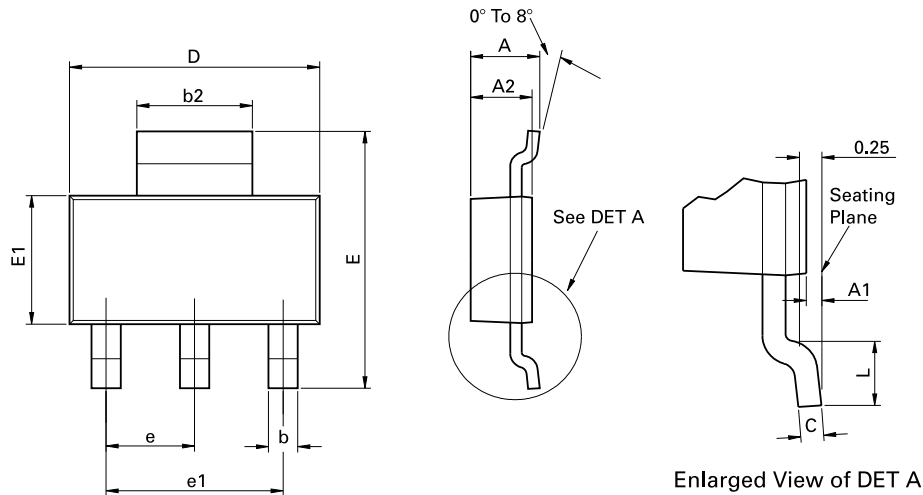
Switching time waveforms



Switching time test circuit

# ZXMN6A25G

## Package outline - SOT223



Conforms to JEDEC TO-261 AA Issue B

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min	Max	Min	Max		Min	Max	Min	Max
A	-	1.80	-	0.071	e	2.30 BSC		0.0905 BSC	
A1	0.02	0.10	0.0008	0.004	e1	4.60 BSC		0.181 BSC	
b	0.66	0.84	0.026	0.033	E	6.70	7.30	0.264	0.287
b2	2.90	3.10	0.114	0.122	E1	3.30	3.70	0.130	0.146
C	0.23	0.33	0.009	0.013	L	0.90	-	0.355	-
D	6.30	6.70	0.248	0.264	-	-	-	-	-

**Note:** Controlling dimensions are in millimeters. Approximate dimensions are provided in inches.

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"Obsolete"	Production has been discontinued

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